## NSN 6625-01-433-4400

Semiconductor Device Test Set - Page 1 of 1



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Single item w/housing

## **Test Type For Which Designed:**

Parametric characterization of semiconductors

## **Special Features:**

3.5 inch ms-dos compatible disk storage; 16v, 80v, 400v, 2000v ranges

Shelf Life:

N/a

**Unit Of Measure:** 

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Demilitarization:

Yes - demil/mli

Fiig:

T228-a